

Notice of References Cited	Application/Control No. 10/550,646		Applicant(s)/Patent Under Reexamination ANDOLFATTO ET AL.	
	Examiner Binh X. Tran		Art Unit 1792	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,850,668	11-1974	Heffer, John Philip	428/408
*	B	US-5,864,051	01-1999	Iwasawa et al.	568/479
*	C	US-6,132,653	10-2000	Hunt et al.	264/5
*	D	US-2004/0077494	04-2004	LaBarge et al.	502/303
*	E	US-2007/0184208	08-2007	Sharma et al.	427/532
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.